Notice of Allowability	Application No.	Applicant(s)
	10/707.358	WANG, YU-PIAO
	Examiner	Art Unit
	Shouxiang Hu	2811
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.		
1. X This communication is responsive to the 02-24-2005 Amendment.		
2. X The allowed claim(s) is/are 20,21,26 and 27.		
3. X The drawings filed on <u>03 December 2003</u> are accepted by the Examiner.		
 4. Acknowledgment is made of a claim for foreign priority unapplement and all bloomes of the priority documents have all certified copies of the priority documents have all copies of the priority documents have all copies of the certified copies of the priority documents have all copies of the certified copies of the priority documents have all copies of the certified copies of the priority documents have all copies of the priority doc	e been received. The been received in Application No Cuments have been received in this of this communication to file a reply IENT of this application. Itted. Note the attached EXAMINER The ses reason(s) why the oath or declaration.	national stage application from the complying with the requirements R'S AMENDMENT or NOTICE OF ation is deficient.
1) hereto or 2) to Paper No./Mail Date		
(b) including changes required by the attached Examiner's Paper No./Mail Date Identifying indicia such as the application number (see 37 CFR 1, each sheet, Replacement sheet(s) should be labeled as such in the state of the sheet.	.84(c)) should be written on the drawi	ngs in the front (not the back) of
7. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.		
Attachment(s) 1. Notice of References Cited (PTO-892) 2. Notice of Draftperson's Patent Drawing Review (PTO-948) 3. Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. Interview Summary Paper No./Mail Da 7. Examiner's Amend	ent of Reasons for Allowance
	SHOUXIAN PRIMARY EX	NG HU

EXAMINER'S AMENDMENT

An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in an email by Belinda Lee (RN: 46,863) on May 9, 2005.

The application has been amended as follows:

IN THE CLAIMS

Claims 1-19 (canceled).

20. (currently amended) A semiconductor device structure, the structure comprising:

an active region and an isolation region, disposed in proximity to each other on a substrate;

a plurality of gate structures <u>each</u> having a gate conductive layer, disposed on the substrate, wherein <u>each of</u> first portions of the gate structures, disposed on the active region, further comprise a cap layer and a spacer, and second portions of the gate structures, disposed on the isolation region, do not comprise a cap layer and a spacer;

a dielectric layer, disposed above the gate structures;

a self-aligned contact, disposed in the dielectric layer <u>and</u> between two of the first portions of the gate structures; and

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a conductive line, disposed on the dielectric layer, wherein the conductive line electrically connects with the self-aligned contact,

wherein a dielectric constant of the dielectric layer is lower than a dielectric constant of the cap layer and the spacer.

21. (currently amended) The structure of claim 20, wherein the spacer of <u>one of the two</u> the first portions of the gate structures is disposed between the self-aligned contact and the gate conductive layer <u>of said one of the two first portions of the gate structures</u>, and <u>between the self-aligned contact and a remaining part of the cap layer of said one of the two first portions of the gate structures</u>, abutted to the spacer disposed between the self-aligned contact and the gate conductive layer, remains on the first portions of the gate structures.

22-25. (cancelled)

26. (currently amended) The structure of claim 20 further comprising a metal silicide layer formed on a sidewall of <u>each of</u> the gate conductive layers of the second portions of the gate structures.

27. (currently amended) The structure of claim 26, wherein a sidewall of the gate conductive layer of one of the first portions of the gate structures has a sidewall that is not adjacent to the self-aligned contact, and said sidewall further comprises a metal silicide layer.

28-31. (Cancelled).

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Allowable Subject Matter

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Claims 20, 21, 26 and 27 are allowed.

Conclusion

Any inquiry concerning this communication or earlier communications from the

examiner should be directed to Shouxiang Hu whose telephone number is 571-272-

1654. The examiner can normally be reached on Monday through Thursday, 7:30 AM

to 6:00 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, Eddie C. Lee can be reached on 571-272-1732. The fax phone number for

the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the

Patent Application Information Retrieval (PAIR) system. Status information for

published applications may be obtained from either Private PAIR or Public PAIR.

Status information for unpublished applications is available through Private PAIR only.

For more information about the PAIR system, see http://pair-direct.uspto.gov. Should

you have questions on access to the Private PAIR system, contact the Electronic

Business Center (EBC) at 866-217-9197 (toll-free).

SH May 0, 2006

May 9, 2005

SHOUXIANG HU PRIMARY EXAMINER

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